TOSHIBA Photocoupler GaAlAs IRED + Photo IC

TLP700

Industrial inverters
Inverter for air conditioners
IGBT/Power MOSFET gate drive

TLP700 consists of a GaAlAs light-emitting diode and an integrated photodetector.

This unit is 6-lead SDIP package. The TLP700 is 50% smaller than the 8-pin DIP and meets the reinforced insulation class requirements of international safety standards. Therefore the mounting area can be reduced in equipment requiring safety standard certification.

The TLP700 is suitable for gate driving circuits for IGBTs or power MOSFETs. In particular, the TLP700 is capable of "direct" gate driving of low-power IGBTs.

Peak output current: ±2.0 A (max)
 Guaranteed performance over temperature: -40 to 100°C
 Supply current: 2 mA (max)
 Power supply voltage: 15 to 30 V

Threshold input current: I_{FLH} = 5 mA (max)
 Switching time (t_{pLH} / t_{pHL}): 500 ns (max)
 Common mode transient immunity: ±15 kV/µs (min)
 Isolation voltage: 5000 Vrms (min)

· Construction mechanical rating

	7.62-mm pitch standard type	10.16-mm pitch TLPXXXF type
Creepage Distance	7.0 mm (min)	8.0 mm (min)
Clearance	7.0 mm (min)	8.0 mm (min)
Insulation Thickness	0.4 mm (min)	0.4 mm (min)

UL recognized: UL1577, File No. E67349

Option (D4) type

TÜV approved: EN60747-5-2

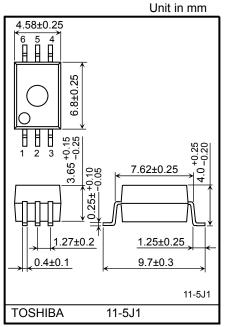
Maximum operating insulation voltage: 890 Vpk Highest permissible over voltage: 8000 Vpk

(Note) When a EN60747-5-2 approved type is needed,

please designate the "Option(D4)"

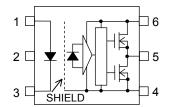
Truth Table

Input	LED	M1	M2	Output
Н	ON	ON	OFF	Н
L	OFF	OFF	ON	L



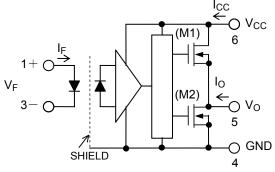
Weight: 0.26 g (typ.)

Pin Configuration (Top View)



- 1: ANODE 2: N.C
- 3: CATHODE 4: GND
- 5: V_O (OUTPUT)
- 6: V_{CC}

Schematic



A 0.1- μ F bypass capacitor must be connected between pins 6 and 4. (See Note 6.)



Absolute Maximum Ratings (Ta = 25 °C)

	Characteristics		Symbol	Rating	Unit
	Forward current		lF	20	mA
	Forward current derating (Ta ≥ 85°	°C)	ΔI _F /ΔTa	-0.54	mA/°C
LED	Peak transient forward current	(Note 1)	IFP	1	Α
	Reverse voltage		V _R	5	V
Junction temperature			Tj	125	°C
	"H" peak output current	Ta=-40 to 100 °C	I _{OPH}	-2.0	Α
ō	"L" peak output current	(Note 2)	I _{OPL}	2.0	Α
Detector	Output voltage		Vo	35	V
ă	Supply voltage		V _{CC}	35	V
	Junction temperature		Tj	125	°C
Oper	rating frequency	(Note 3)	f	50	kHz
Operating temperature range			T _{opr}	-40 to 100	°C
Stora	Storage temperature range			-55 to 125	°C
Lead soldering temperature (10 s) (Note 4)			T _{SOI}	260	°C
Isola	tion voltage (AC, 1 minute, R.H. ≤ 6	60%) (Note 5)	BVS	5000	Vrms

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

- Note 1: Pulse width $P_W \le 1 \mu s$, 300 pps
- Note 2: Exponential waveform pulse width $P_W \le 0.3 \mu s$, $f \le 15 \text{ kHz}$
- Note 3: Exponential waveform I_{OPH} ≥−1.5 A (≤ 0.3 μs), I_{OPL} ≤+1.5 A (≤ 0.3 μs), Ta=100°C
- Note 4: For the effective lead soldering area
- Note 5: Device considered a two-terminal device: pins 1, 2 and 3 paired with pins 4, 5 and 6 respectively.
- Note 6: A ceramic capacitor $(0.1~\mu\text{F})$ should be connected from pin 6 to pin 4 to stabilize the operation of the high gain linear amplifier. Failure to provide the bypassing may impair the switching property. The total lead length between capacitor and coupler should not exceed 1 cm.

Recommended Operating Conditions

Characteristics		Symbol	Min	Тур.	Max	Unit
Input current, ON	(Note 7)	I _{F (ON)}	7.5	_	10	mA
Input voltage, OFF		V _F (OFF)	0	_	0.8	٧
Supply voltage *	(Note 8)	V _{CC}	15	_	30	V
Peak output current		I _{OPH} / I _{OPL}	_	_	± 1.5	Α
Operating temperature		T _{opr}	-40	_	100	°C

^{*} This item denotes operating ranges, not meaning of recommended operating conditions.

Note: Recommended operating conditions are given as a design guideline to obtain expected performance of the device. Additionally, each item is an independent guideline respectively. In developing designs using this product, please confirm specified characteristics shown in this document.

Note 7: Input signal rise time (fall time) $\leq 0.5 \mu s$.

Note 8: If the Vcc rise slope is sharp, an internal circuit might not operate with stability. Please design the Vcc rise slope under $3.0 \text{ V/}\mu\text{s}$.

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Electrical Characteristics (Ta = -40 to 100 °C, unless otherwise specified)

Characteristics		Symbol	Test Circuit	Test Condition		Min	Typ.*	Max	Unit
Forward voltage		V _F	_	I _F = 10 mA, Ta =	25 °C	_	1.57	1.75	V
Temperature coefficient of voltage	forward	ΔV _F /ΔTa	_	I _F = 10 mA		_	-1.8	_	mV/°C
Input reverse current		I _R	_	V _R = 5 V, Ta = 25	5 °C	_	_	10	μА
Input capacitance		C _T	_	V =0 V, f = 1 MHz	z, Ta = 25 °C	_	100	_	pF
	"H" Level	I _{OPH1}	1	V _{CC} = 15 V	V ₆₋₅ = 3.5 V	_	-1.4	-1.0	
Output current	n Level	I _{OPH2}	'	$I_F = 5 \text{ mA}$	V ₆₋₅ = 7 V	_	_	-1.5	,
(Note 9)	"L" Level	I _{OPL1}	2	V _{CC} = 15 V	V ₅₋₄ = 2.5 V	1.0	1.4	_	- A -
	L Levei	I _{OPL2}	2	$I_F = 0 \text{ mA}$	V ₅₋₄ = 7 V	1.5	_	_	
Outrout valte as	"H" Level	V _{OH}	3	V_{CC1} =+15V, V_{EE1} =-15V $R_L = 200\Omega$, $I_F = 5$ mA		11	13.7	_	V
Output voltage	"L" Level	V _{OL}	4	V_{CC1} =+15V, V_{EE1} =-15V $R_L = 200\Omega, V_F = 0.8 \text{ V}$		_	-14.9	-12.5	V
Supply current	"H" Level	Icch	5	V _{CC} = 30 V	I _F = 10 mA	_	1.3	2.0	mA
Supply current	"L" Level	I _{CCL}	6	V _O =Open	I _F = 0 mA	_	1.3	2.0	IIIA
Threshold input current	$L \rightarrow H$	I _{FLH}	_	V _{CC} = 15 V, V _O >	- 1 V	_	1.8	5	mA
Threshold input voltage	$H \rightarrow L$	V _{FHL}	_	V _{CC} = 15 V, V _O < 1 V		8.0	_	_	V
Supply voltage V _{CC} — —		_	15	_	30	V			
LIVI O through hold			_	V _O > 2.5V, I _F = 5 mA		11.0	12.5	13.5	V
UVLO thresh hold		V _{UVLO-}		V _O < 2.5V, I _F = 5	mA	9.5	11.0	12.0	V
UVLO hysteresis		UVLO _{HYS}	_	_	_		1.5		V

(*): All typical values are at Ta = 25°C

Note 9: Duration of lo time \leq 50 μ s, 1 pulse

Note 10: This product is more sensitive than conventional products to electrostatic discharge (ESD) owing to its low power consumption design.

It is therefore all the more necessary to observe general precautions regarding ESD when handling this component.

Isolation Characteristics (Ta = 25 °C)

Characteristic	Symbol	Test Condition	Min	Тур.	Max	Unit
Capacitance input to output	CS	Vs = 0 V , f = 1MHz (Note 5)	_	1.0		pF
Isolation resistance	R _S	R.H. ≤ 60 %, V _S = 500 V (Note 5)	1×10 ¹²	10 ¹⁴	_	Ω
		AC, 1 minute	5000	_	_	Vrms
Isolation voltage	BVS	AC, 1 second, in oil	_	10000	_	VIIIIS
		DC, 1 minute, in oil	_	10000		Vdc

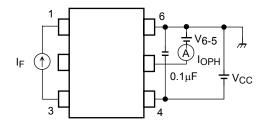
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Switching Characteristics (Ta = −40 to 100 °C, unless otherwise specified)

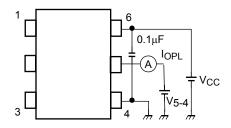
Characteristics Symbol Test Circuit Test Condition		ndition	Min	Тур.*	Max	Unit			
Propagation delay time	$L \rightarrow H$	^t pLH			$I_F = 0 \rightarrow 5 \text{ mA}$	50	_	500	
Fropagation delay time	H→L	tpHL		V _{CC} = 30 V	$I_F = 5 \rightarrow 0 \text{ mA}$	50	_	500	
Output rise time (10–90 %)		t _r	7	$R_g = 20 \Omega$ $C_g = 10 \text{ nF}$	$I_F = 0 \rightarrow 5 \text{ mA}$	_	50	_	ns
Output fall time (90–10 %)		t _f			$I_F = 5 \rightarrow 0 \text{ mA}$	_	50	_	
Switching time dispersion between ON and OFF		tpнL-tpLн			$I_F = 0 \leftrightarrow 5 \text{ mA}$		_	250	
Common mode transient i at HIGH level output	mmunity	CM _H	. 8	V _{CM} =1000 Vp-p	$I_F = 5 \text{ mA}$ $V_{O \text{ (min)}} = 26 \text{ V}$	-15	_	_	kV/μs
Common mode transient i at LOW level output	mmunity	CML	0	Ta = 25 °C V _{CC} = 30 V	$I_F = 0 \text{ mA}$ $V_{O \text{ (max)}} = 1 \text{ V}$	15	_		κν/μδ

^{(*):} All typical values are at Ta = 25 °C.

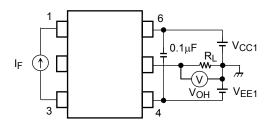
Test Circuit 1: IOPH



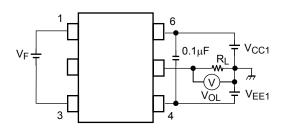
Test Circuit 2: IOPL



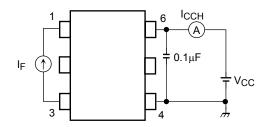
Test Circuit 3: V_{OH}



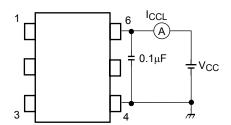
Test Circuit 4: V_{OL}



Test Circuit 5: Icch

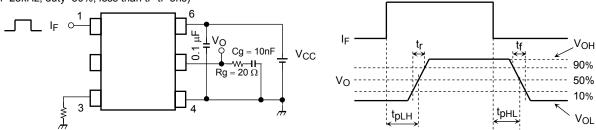


Test Circuit 6: I_{CCL}

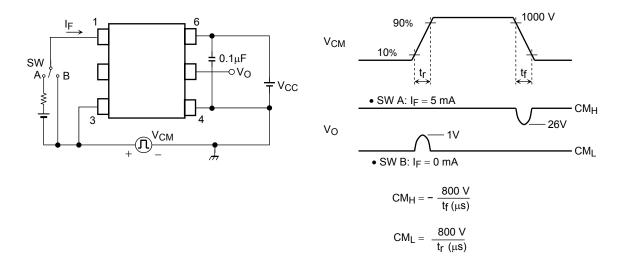


Test Circuit 7: t_{pLH} , t_{pHL} , t_r , t_f , $\mid t_{pHL}$ - $t_{pLH} \mid$

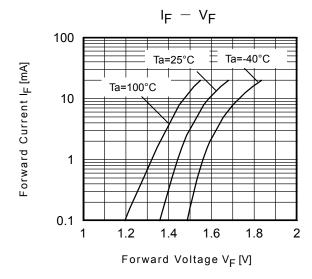
(f=25kHz, duty=50%, less than tr=tf=5ns)

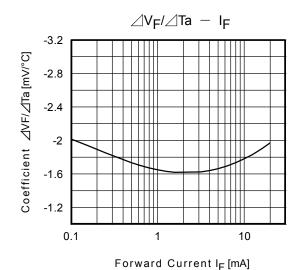


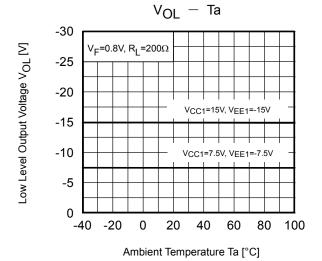
Test Circuit 8: CMH, CML

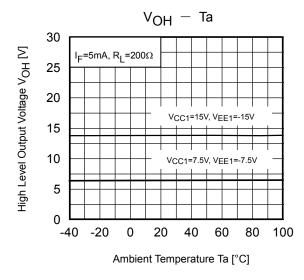


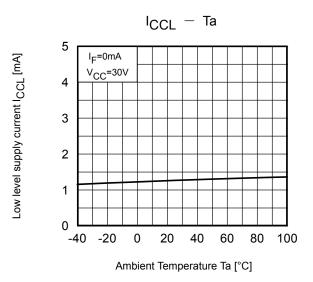
 CM_{L} (CM_H) is the maximum rate of rise (fall) of the common mode voltage that can be sustained with the output voltage in the LOW (HIGH) state.

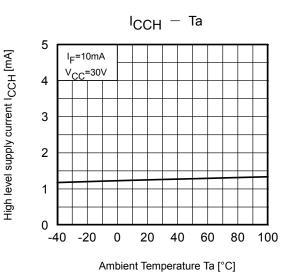




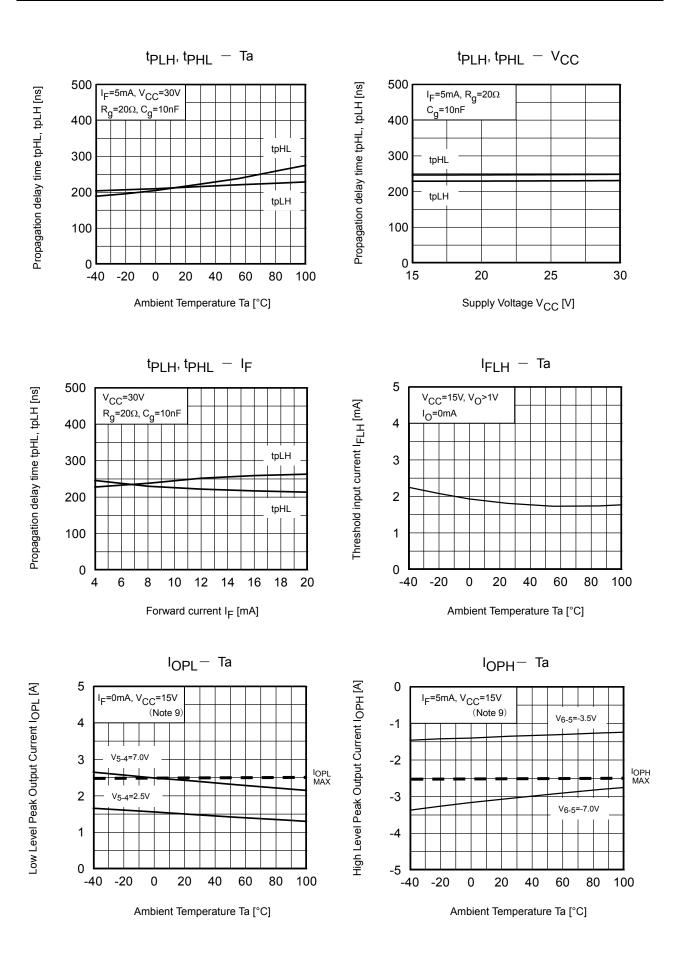


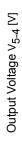


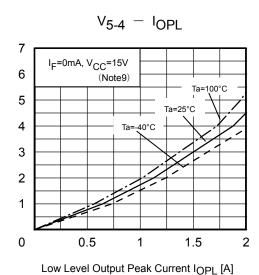




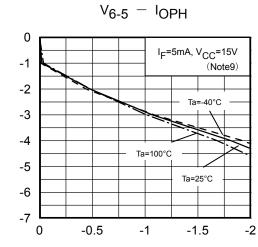
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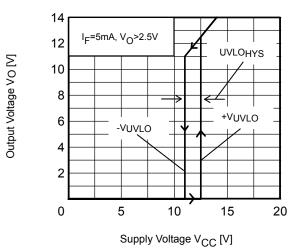


Output Voltage V₆₋₅ [V]

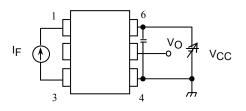


High Level Output Peak Current IOPH [A]





**Test Circuit : VO(VUVLO) - VCC



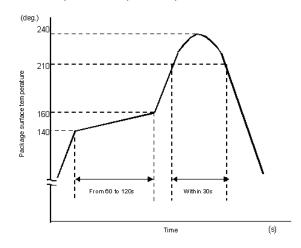
*: The above graphs show typical characteristics.

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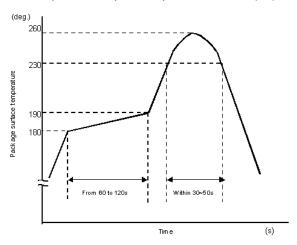
Soldering and Storage

(1) Precautions for Soldering

- 1) When Using Soldering Reflow
 - An example of a temperature profile when Sn-Pb eutectic solder is used:



• An example of a temperature profile when lead(Pb)-free solder is used:



- Reflow soldering must be performed once or twice.
- The mounting should be completed with the interval from the first to the last mountings being 2 weeks.
- 2) When using soldering Flow (Applicable to both eutectic solder and Lead(Pb)-Free solder)
 - Apply preheating of 150 deg.C for 60 to 120 seconds.
 - Mounting condition of 260 deg.C or less within 10 seconds is recommended.
 - Flow soldering must be performed once
- 3) When using soldering Iron (Applicable to both eutectic solder and Lead(Pb)-Free solder)
 - Complete soldering within 10 seconds for lead temperature not exceeding 260 deg.C or within 3 seconds not exceeding 350 deg.C.
 - Heating by soldering iron must be only once per 1 lead

(2) Precautions for General Storage

- 1) Do not store devices at any place where they will be exposed to moisture or direct sunlight.
- 2) When transportation or storage of devices, follow the cautions indicated on the carton box.
- 3) The storage area temperature should be kept within a temperature range of 5 degree C to 35 degree C, and relative humidity should be maintained at between 45% and 75%.
- 4) Do not store devices in the presence of harmful (especially corrosive)gases, or in dusty conditions.
- 5) Use storage areas where there is minimal temperature fluctuation. Because rapid temperature changes can cause condensation to occur on stored devices, resulting in lead oxidation or corrosion, as a result, the solderability of the leads will be degraded.
- 6) When repacking devices, use anti-static containers.
- 7) Do not apply any external force or load directly to devices while they are in storage.
- 8) If devices have been stored for more than two years, even though the above conditions have been followed, it is recommended that solderability of them should be tested before they are used.

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Specifications for Embossed-Tape Packing (TP) for SDIP6 Type Photocoupler

1. Applicable Package

Package Name	Product Type
SDIP6	Photocouplers

2. Product Naming System

Type of package used for shipment is denoted by a symbol suffix after a product number. The method of classification is as below.



3. Tape Dimensions

3.1 Orientation of Devices in Relation to Direction of Tape Movement

Device orientation in the recesses is as shown in Figure 1.

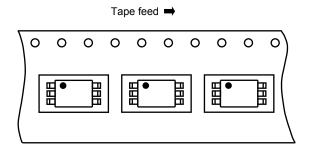


Figure 1 Device Orientation

- 3.2 Tape Packing Quantity: 1500 devices per reel
- 3.3 Empty Device Recesses Are as Shown in Table 1.

Table 1 Empty Device Recesses

	Standard	Remarks
Occurrences of 2 or more successive empty device recesses	0	Within any given 40-mm section of tape, not including leader and trailer
Single empty device recesses	6 devices (max) per reel	Not including leader and trailer

3.4 Start and End of Tape:

The start of the tape has 30 or more empty holes. The end of the tape has 30 or more empty holes and two empty turns only for a cover tape.

3.5 Tape Specification

- (1) Tape material: Plastic (protection against electrostatics)
- (2) Dimensions: The tape dimensions are as shown in Figure 2 and Table 2.

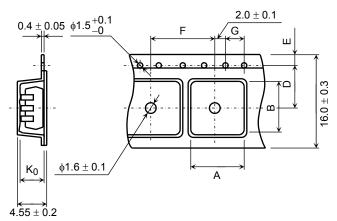


Figure 2 Tape Forms

Table 2 Tape Dimension

Unit: mm

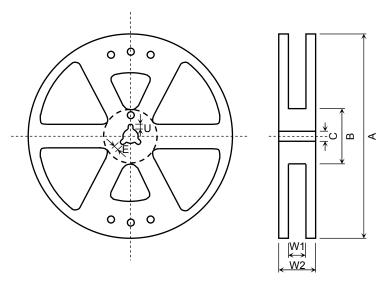
Unless otherwise specified: ±0.1

		Critical dutor wild appointed. ±e.1
Symbol	Dimension	Remark
Α	10.4	_
В	5.1	_
D	7.5	Center line of indented square hole and sprocket hole
Е	1.75	Distance between tape edge and hole center
F	12.0	Cumulative error $^{+0.1}_{-0.3}$ (max) per 10 feed holes
G	4.0	Cumulative error $^{+0.1}_{-0.3}$ (max) per 10 feed holes
K ₀	4.1	Internal space



3.6 Reel

- (1) Material: Plastic
- (2) Dimensions: The reel dimensions are as shown in Figure 3 and Table 3.



Unit: mm 記号 寸 法 $\phi 380 \pm 2$ Α В $\phi 80 \pm 1$ С $\varphi 13 \pm 0.5$ Ε 2.0 ± 0.5 U 4.0 ± 0.5 W1 $17.5\pm0.5\,$ W2 $21.5\pm1.0\,$

Table 3 Reel Dimension

Figure 3 Reel Forms

4. Packing

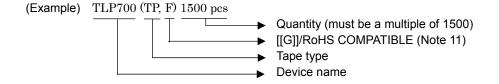
Either one reel or five reels of photocouplers are packed in a shipping carton.

5. Label Indication

The carton bears a label indicating the product number, the symbol representing classification of standard, the quantity, the lot number and the Toshiba company name.

6. Ordering Method

When placing an order, please specify the product number, the CTR rank, the tape type and the quantity as shown in the following example.



Note 11 :Please contact your TOSHIBA sales representative for details as to environmental matters such as the RoHS compatibility of Product.

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RoHS is the Directive 2002/95/EC of the European Parliament and of the Council of 27 January 2003 on the restriction of the use of certain hazardous substances in electrical and electronics equipment.

EN60747-5-2 Option:(D4)

Attachment : Specifications for EN60747-5-2 option: (D4)

Types: TLP700, TLP700F

Type designations for "option: (D4)", which are tested under EN60747 requirements.

Ex.: TLP700 (D4-TP,F) D4 : EN60747 option

TP: Standard tape & reel type

F: [[G]]/RoHS COMPATIBLE (Note 11)

Note: Use TOSHIBA standard type number for safety standard application.

Ex.: TLP700 (D4-TP,F) → TLP700

EN60747 Isolation Characteristics

Description	Symbol	Rating	Unit		
Application classification for rated mains voltage≤300V _{rms} for rated mains voltage≤600V _{rms}		I-IV I-III	_		
Climatic classification			40/ 100 / 21	_	
Pollution degree			2	_	
Maximum operating insulation voltage	TLPxxx type	\/	890	Vala	
Maximum operating insulation voltage	TLPxxxFtype	V _{IORM}	1140	Vpk	
Input to output test voltage, method A	TLPxxx type		1335	Vpk	
Vpr=1.5×V _{IORM} , type and sample test tp=10s, partial discharge<5pC	TLPxxxFtype	Vpr	1710		
Input to output test voltage, method B	TLPxxx type		1670	Vpk	
Vpr=1.875×V _{IORM} , 100% production test t_p =1s, partial discharge<5pC	TLPxxxFtype	Vpr	2140		
Highest permissible overvoltage (transient overvoltage, t _{pr} = 60s)		V _{TR}	8000	Vpk	
Safety limiting values (max. permissible ratings in case of fault, also refer to thermal derating curve) current (input current I_F , P_{si} = 0) power (output or total power dissipation) temperature			300 700 150	mA mW °C	
Insulation resistance, V_{IO} =500V, Ta=25°C V_{IO} =500V, Ta=100°C V_{IO} =500V, Ta=Tsi		Rsi	$\begin{array}{c} \geq 10^{12} \\ \geq 10^{11} \\ \geq 10^{9} \end{array}$	Ω	

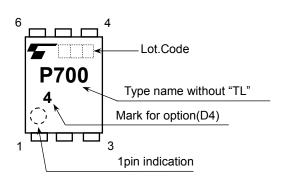
Insulation Related Specifications

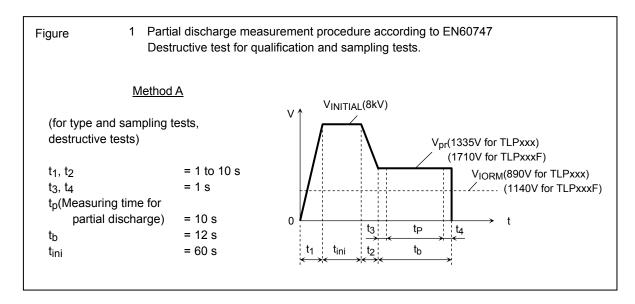
		7.62mm pitch TLPxxx type	10.16mm pitch TLPxxxF type	
Minimum creepage distance	Cr	7.0mm	8.0mm	
Minimum clearance	CI	7.0mm	8.0mm	
Minimum insulation thickness	ti	0.4mm		
Comperative tracking index	СТІ	175		

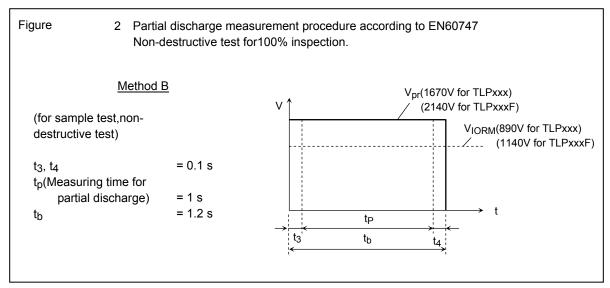
- 1. If a printed circuit is incorporated, the creepage distance and clearance may be reduced below this value. (e.g.at a standard distance between soldering eye centres of 7.5mm). If this is not permissible, the user shall take suitable measures.
- 2. This photocoupler is suitable for 'safe electrical isolation' only within the safety limit data. Maintenance of the safety data shall be ensured by means of protective circuits.

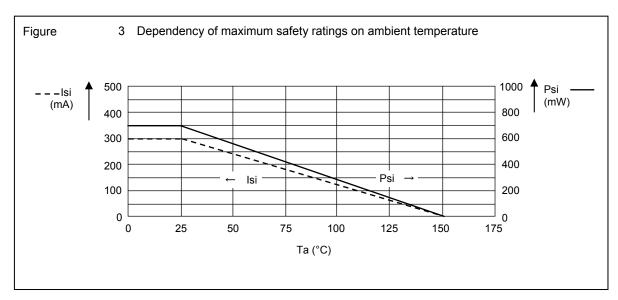
Marking on product for EN60747 : 4

Marking Example:









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